

**Notice of References Cited**Application/Control No.  
**09/529,734**Applicant(s)/Patent Under Reexam  
**HINZE**Examiner  
**Pak, J.**Art Unit  
**1616**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	5,427,667	6/1995	Bakhir et al.	204	260
B	5,871,623	2/1999	Bakhir et al.	204	260
C					
D					
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F					
G					
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K					
L					
M					

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	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Country</b>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
N	7-328628	12/1995	JP	Shigematsu et al.	----	----
O						
P						
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R						
S						
T						

**NON-PATENT DOCUMENTS**

	<b>Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages</b>
U	WPIDS abstract, accession no. 1996-096021, abstracting RU 2036662 (6/1995), entry date of the abstract: 3/8/1996.
V	Chemical Abstract 124:155560k, abstracting JP 7-328628 (12/1995), abstract date: 3/1996.
W	
X	

<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.